December 2004



FDC5612

60V N-Channel PowerTrench® MOSFET

General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers.

These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable $R_{_{\rm DS(ON)}}$ specifications.

The result is a MOSFET that is easy and safer to drive (even at very high frequencies), and DC/DC power supply designs with higher overall efficiency.

Features

- 4.3 A, 60 V. $R_{DS(ON)} = 0.055 \Omega @ V_{GS} = 10 V$ $R_{DS(ON)} = 0.064 \Omega @ V_{GS} = 6 V$
- Low gate charge (12.5nC typical).
- Fast switching speed.
- High performance trench technology for extremely low R_{DS(ON)}.
- SuperSOT[™]-6 package: small footprint (72% smaller than standard SO-8); low profile (1mm thick).





SuperSOT™-6

Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		60	V
V _{GSS}	Gate-Source Voltage		<u>+</u> 20	V
ID	Drain Current - Continuous	(Note 1a)	4.3	А
	Drain Current - Pulsed		20	
PD	Power Dissipation for Single Operation	(Note 1a)	1.6	W
		(Note 1b)	0.8	
T _J , T _{stq}	Operating and Storage Junction Temperature Range		-55 to +150	∘C

Thermal Characteristics

R _{ÐJA}	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78	∘C/W	
R _θ JC	Thermal Resistance, Junction-to-Case	(Note 1)	30	∘C/W	

Package Outlines and Ordering Information

	Device Marking	Device	Reel Size	Tape Width	Quantity
562 FDC5612 7" 8mm	.562	FDC5612	7"	8mm	3000 units

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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_D = 250 \mu A$	60			V
<u>Δ</u> BVdss ΔTJ	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		58		mV/∘C
DSS	Zero Gate Voltage Drain Current	$V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}$			1	μA
GSSF	Gate-Body Leakage Current, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
	Gate-Body Leakage Current, Reverse	V_{GS} = -20 V, V_{DS} = 0 V			-100	nA
On Char	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	2	2.2	4	V
$\Delta VGS(th)$ $\Delta T_{,l}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C		-5.5		mV/∘C
R _{DS(on)}	Static Drain-Source On-Resistance	$V_{GS} = 10 V, I_D = 4.3 A$ $V_{GS} = 10 V, I_D = 4.3 A, T_J = 125 \circ C$ $V_{GS} = 6 V, I_D = 4 A$		0.042 0.072 0.048	0.055 0.094 0.064	Ω
D(on)	On-State Drain Current	$V_{GS} = 10 \text{ V}, \text{ V}_{DS} = 5 \text{ V}$	10			Α
g _{FS}	Forward Transconductance	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 4.3 \text{ A}$		14		S
Dvnamio	c Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$		650		pF
C _{oss}	Output Capacitance	f = 1.0 MHz		80		pF
C _{rss}	Reverse Transfer Capacitance	1		35		pF
Switchir	ng Characteristics (Note 2)					
d(on)	Turn-On Delay Time	$V_{DD} = 30 V, I_D = 1 A,$		11	20	ns
tr	Turn-On Rise Time	V_{GS} = 10 V, R_{GEN} = 6 Ω		8	18	ns
t _{d(off)}	Turn-Off Delay Time	1		19	35	ns
f	Turn-Off Fall Time	1		6	15	ns
Qg	Total Gate Charge	$V_{DS} = 30 \text{ V}, \text{ I}_{D} = 4.3 \text{ A},$		12.5	18	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V		2.4		nC
Q _{gd}	Gate-Drain Charge	1		2.6		nC
Drain-Sc	ource Diode Characteristics an	d Maximum Ratings				
	Maximum Continuous Drain-Source Did	-			1.3	А
ls						

b) 156 °C/W when mounted on a minimum pad.

2. Pulse Test: Pulse Width $\pm\,300\,\mathrm{ms},$ Duty Cycle $\pm\,2.0\%$

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